Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/645,796	SHIBUYA ET AL.	
Examiner	Art Unit	
Richard L. Schilling	1752	

	SEAR	CHED	
SEARCHED			
Class	Subclass	Date	Examiner
430	276.1 286.1 287.1 964	6-1-06	N
	,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
West (see 14:5 tc)-y 21, 24, 27 210, 211)	6-1-06	n	